

MOSFET - N-Channel Shielded Gate POWERTRENCH®

150 V, 2 A, 236 m Ω

FDT86246

Description

This N-Channel MOSFET is produced using Fairchild onsemi advanced PowerTrench® Process that has been optimized for $R_{DS(on)}$, switching performance and ruggedness.

Features

- Max $R_{DS(on)} = 236 \text{ m}\Omega$ at $V_{GS} = 10 \text{ V}$, $I_D = 2 \text{ A}$
- Max $R_{DS(on)} = 329 \text{ m}\Omega$ at $V_{GS} = 6 \text{ V}$, $I_D = 1.7 \text{ A}$
- High Performance Trench Technology for Extremely Low R_{DS(on)}
- High Power and Current Handling Capability in a Widely Used Surface Mount Package
- Fast Switching Speed
- 100% UIL Tested
- These Devices are Pb-Free and are RoHS Compliant

Typical Applications

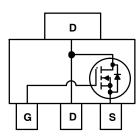
- Load Switch
- Primary Switch

MOSFET Maximum Ratings $T_A = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Ratings	Unit	
V _{DS}	Drain to Source Voltage	le 150		
V _{GS}	Gate to Source Voltage	±20	V	
I _D	Drain Current -Continuous (Note 1a)	2	Α	
	-Pulsed	8		
E _{AS}	Single Pulse Avalanche Energy (Note 3)	8	mJ	
P _D	Power Dissipation (Note 1a)	2.2	W	
	Power Dissipation (Note 1b)	1.0		
T _J , T _{STG}	Operating and Storage Junction Temperature Range	-55 to +150	°C	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

SOT-223 CASE 318H



MARKING DIAGRAM



Z = Assembly Plan Code XY = Date Code (Year & week) 86246 = Specific Device Code

ORDERING INFORMATION

Device	Package	Shipping [†]
FDT86246	SOT-223 (Pb-Free)	4000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

THERMAL CHARACTERISTICS

Symbol	Symbol Parameter		Unit
$R_{ heta JC}$	Thermal Resistance, Junction to Case (Note 1)	12	°C/W
$R_{ heta JA}$	R _{θJA} Thermal Resistance, Junction to Ambient (Note 1a)		

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ELECTRICAL CHARACTERISTICS T_A = 25°C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
ff Characteristic	cs	•				
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	150	-	_	V
$\frac{\Delta BV_{DSS(th)}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I _D = 250 μA, referenced to 25°C	-	104	-	mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 120 V, V _{GS} = 0 V	-	-	1	μΑ
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$	-	-	±100	nA
n Characteristic	es					
V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$	2.0	3.1	4.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I_D = 250 μA, referenced to 25°C	-	-9	-	mV/°C
R _{DS(on)}	Static Drain to Source On Resistance	V _{GS} = 10 V, I _D = 2 A	-	194	236	mΩ
		V _{GS} = 6 V, I _D = 1.7 A	-	231	329	
		$V_{GS} = 10 \text{ V}, I_D = 2 \text{ A}, T_J = 125^{\circ}\text{C}$	-	349	425	
9FS	Forward Transconductance	V _{DS} = 10 V, I _D = 2 A	-	5	-	S
ynamic Charact	eristics					
C _{iss}	Input Capacitance	$V_{DS} = 75 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	-	161	215	pF
C _{oss}	Output Capacitance		-	21	30	pF
C _{rss}	Reverse Transfer Capacitance		-	1.6	5	pF
R_{g}	Gate Resistance		-	0.9	_	Ω
witching Charac	cteristics					
t _{d(on)}	Turn-On Delay Time	$V_{DD} = 75 \text{ V}, I_D = 2 \text{ A},$	_	7.8	16	ns
t _r	Rise Time	V_{GS} = 10 V, R_{GEN} = 6 Ω	_	2.3	10	ns
t _{d(off)}	Turn-Off Delay Time		-	4.6	10	ns
t _f	Fall Time		-	1.2	10	ns
$Q_{g(TOT)}$	Total Gate Charge	V _{GS} = 0 V to 10 V,	-	2.9	4	nC
Q _{g(TOT)}	Total Gate Charge	V _{GS} = 0 V to 5 V	-	1.7	3	-
Q_{gs}	Total Gate Charge	V _{DD} = 75 V,	-	0.9	-	nC
Q _{gd}	Gate to Drain "Miller" Charge	$I_D = 2 A$	-	0.8	-	nC

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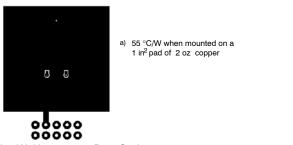
ELECTRICAL CHARACTERISTICS (continued) $T_A = 25^{\circ}C$ unless otherwise noted

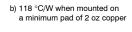
Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
Drain-Source Diode Characteristics						
V _{SD}	Source to Drain Diode Forward Voltage	V _{GS} = 0 V, I _S = 2 A (Note 2)	-	0.84	1.3	V
t _{rr}	Reverse Recovery Time	$I_F = 2 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}$	-	44	71	ns
Q _{rr}	Reverse Recovery Charge		1	31	49	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

NOTES:

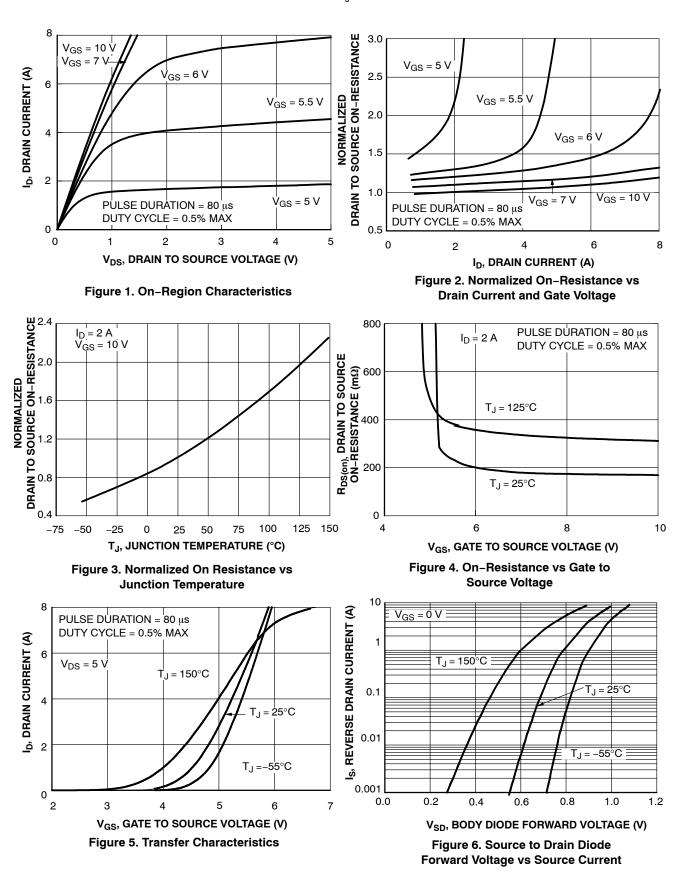
1. $R_{\theta JA}$ is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.



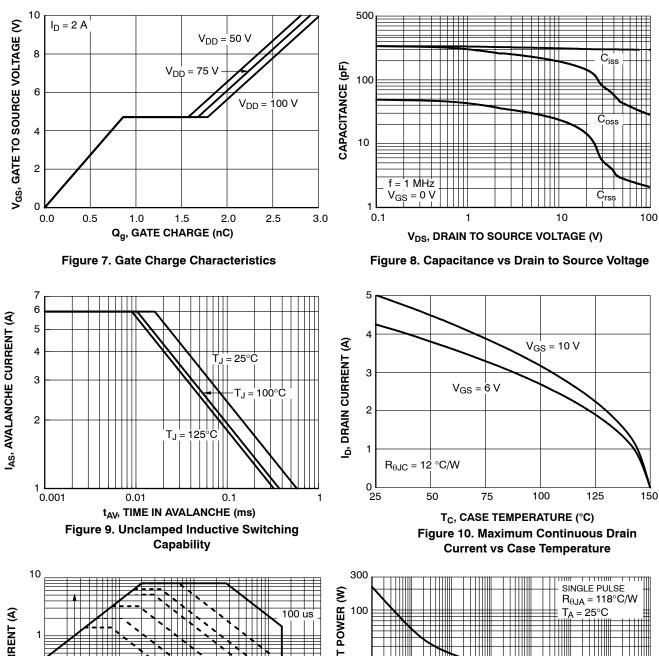


- 2. Pulse Test : Pulse Width < 300 μs , Duty Cycle < 2.0% 3. Starting T $_J$ = 25 °C; N–ch: L = 1.0 mH, I $_{AS}$ = 4.0 A, V $_{DD}$ = 135 V, V $_{GS}$ = 10 V.

TYPICAL CHARACTERISTICS T. = 25°C UNLESS OTHERWISE NOTED



TYPICAL CHARACTERISTICS (CONTINUED) T, = 25°C UNLESS OTHERWISE NOTED



100 us 10

0.1

 ${
m V_{DS}}, {
m DRAIN}$ to SOURCE VOLTAGE (V) Figure 11. Forward Bias Safe Operating Area

10

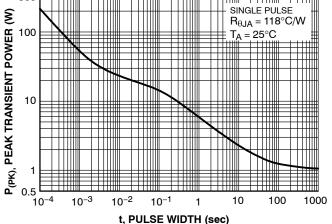


Figure 12. Single Pulse Maximum Power Dissipation

500

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TYPICAL CHARACTERISTICS (CONTINUED) $T_J = 25^{\circ}C$ UNLESS OTHERWISE NOTED

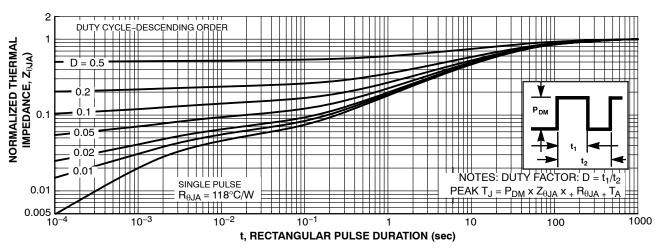
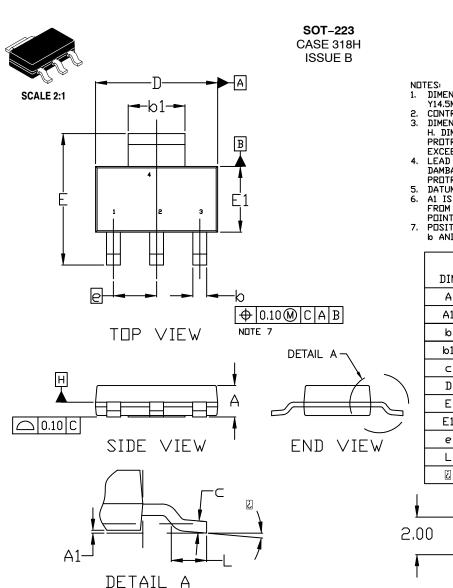


Figure 13. Junction-to-Ambient Transient Thermal Response Curve



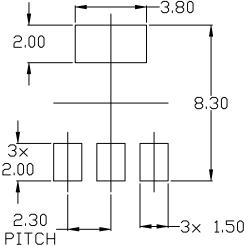


DATE 13 MAY 2020

- DIMENSIONING AND TOLERANCING PER ASME
- DIMENSIDNING AND TOLERANCING PER ASME Y14.5M, 2009.
 CONTROLLING DIMENSION: MILLIMETERS DIMENSIONS D & E1 ARE DETERMINED AT DATUM H. DIMENSIONS DO NOT INCLUDE MOLD FLASH, PROTRUSIONS DR GATE BURRS. SHALL NOT EXCEED 0.23mm PER SIDE.
 LEAD DIMENSIONS & AND &1 DO NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBBAR PROTRUSION. ALLOWABLE DAMBBAR PROTRUSION IS 0.08mm PER SIDE.
 DATUMS A AND B ARE DETERMINED AT DATUM H. A1 IS DEFINED AS THE VERTICAL DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT OF THE PACKAGE BODY.
 POSITIONAL TOLERANCE APPLIES TO DIMENSIONS & AND &1.

- b AND b1.

	MILLIMETERS			
DIM	MIN.	N□M.	MAX.	
Α			1.80	
A1	0.02	0.06	0.11	
b	0.60	0.74	0.88	
b1	2.90	3.00	3.10	
С	0.24		0.35	
D	6.30	6.50	6.70	
E	6.70	7.00	7.30	
E1	3,30	3.50	3.70	
е	2.30 BSC			
L	0.25			
į.	0*		10°	



GENERIC MARKING DIAGRAM*



= Assembly Location Υ

= Year

W = Work Week

XXXXX = Specific Device Code

= Pb-Free Package

(Note: Microdot may be in either location)

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.

RECOMMENDED MOUNTING FOOTPRINT

For additional information on our Pb-Free strategy and soldering details, please download the IIN Semiconductor Soldering and Mounting Techniques Reference Manual, SILDERRM/D.

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